Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/824,123	HAN ET AL.	
Examiner	Art Unit	
Michael La Villa	1775	

SEARCHED					
Class	Subclass	Date	Examiner		
428	655, 660, 656, 639, 632, 633	2/17/2006	ML		
428	935				
422	241, 129				
119	715, 726				
119	504, 506	2/17/2006	ML.		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

	CH NOTES EARCH STRATEG	Y)
	DATE	EXMR
WEST SEARCH	2/17/2006	ML
Inventor Search	2/17/2006	ML